

AOTF260L

60V N-Channel MOSFET

General Description

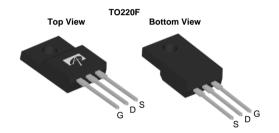
The AOTF260L uses Trench MOSFET technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{\rm DS(ON)},$ Ciss and Coss. This device is ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

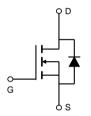
Product Summary

 $\begin{array}{lll} V_{DS} & 60V \\ I_{D} \; (at \; V_{GS} \! = \! 10V) & 92A \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 10V) & < 2.6 m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \! = \! 6V) & < 3.0 m\Omega \end{array}$

100% UIS Tested 100% R_g Tested







Absolute Maximum Ratings T _A =25°C unless otherwise noted								
		Symbol	Maximum	Units				
Drain-Source Voltage		V_{DS}	60	V				
Gate-Source Voltage		V_{GS}	±20	V				
Continuous Drain	T _C =25°C		92					
Current ^G	T _C =100°C	ID	66.5	A				
Pulsed Drain Current ^C		I _{DM}	368					
Continuous Drain	T _A =25°C	1	19	A				
Current	T _A =70°C	IDSM	15	^				
Avalanche Current C		I _{AS}	128	A				
Avalanche energy L=0.1mH ^C		E _{AS}	819	mJ				
	T _C =25°C	P _D	46.5	W				
Power Dissipation ^B	T _C =100°C	' D	23.5	VV				
	T _A =25°C		1.9	W				
Power Dissipation ^A	T _A =70°C	P _{DSM}	1.2	VV				
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 175	°C				

Thermal Characteristics								
Parameter	Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient ^A	t ≤ 10s	D	12	15	°C/W			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	54	65	°C/W			
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	2.6	3.2	°C/W			



Electrical Characteristics (T_.=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V			1	μА			
		T _J =58	5°C		5	·			
I_{GSS}	Gate-Body leakage current	$V_{DS}=0V$, $V_{GS}=\pm20V$			±100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	2.2	2.7	3.2	V			
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V	368			Α			
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =20A		2.1	2.6				
		T _J =125	5°C	3.5	4.3	mΩ			
		V_{GS} =6V, I_D =20A		2.3	3.0				
g _{FS}	Forward Transconductance	$V_{DS}=5V$, $I_{D}=20A$		68		S			
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.65	1	V			
Is	Maximum Body-Diode Continuous Current				55	Α			
DYNAMIC	CPARAMETERS								
C _{iss}	Input Capacitance			11800		pF			
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =30V, f=1MHz		1360		pF			
C_{rss}	Reverse Transfer Capacitance			40		pF			
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	0.5	1	1.5	Ω			
SWITCHI	NG PARAMETERS								
Q _g (10V)	Total Gate Charge			150	210	nC			
Q_{gs}	Gate Source Charge	$V_{GS}=10V, V_{DS}=30V, I_{D}=20A$		40		nC			
Q_{gd}	Gate Drain Charge			15		nC			
t _{D(on)}	Turn-On DelayTime			30		ns			
t _r	Turn-On Rise Time	$V_{GS}=10V, V_{DS}=30V, R_{L}=1.5\Omega$	2,	27		ns			
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		74		ns			
t _f	Turn-Off Fall Time			12		ns			
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, dI/dt=500A/μs		32		ns			
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =20A, dI/dt=500A/μs		200		nC			

A. The value of R_{NJA} is measured with the device mounted on 1in^2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R _{0JA} and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

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B. The power dissipation P_D is based on T_{J(MAX)}=175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=175° C. Ratings are based on low frequency and duty cycles to keep initial T_{.1}=25° C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

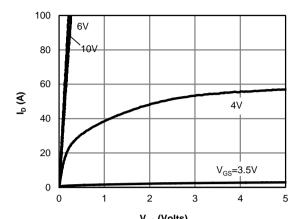
E. The static characteristics in Figures 1 to 6 are obtained using <300 µs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating. G. The maximum current rating is package limited.

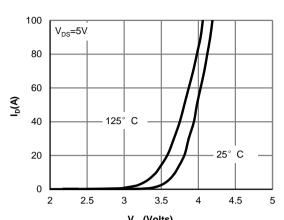
H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



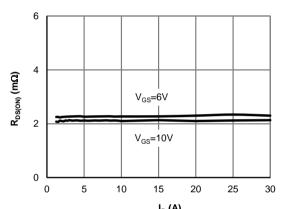
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



V_{DS} (Volts) Fig 1: On-Region Characteristics (Note E)



V_{GS}(Volts)
Figure 2: Transfer Characteristics (Note E)



 $I_{D}\left(\mathbf{A}\right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

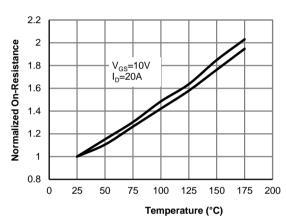
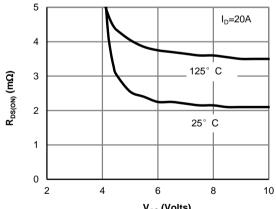
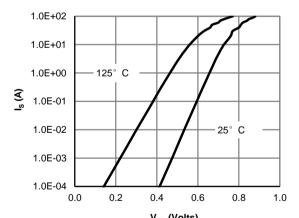


Figure 4: On-Resistance vs. Junction Temperature (Note E)



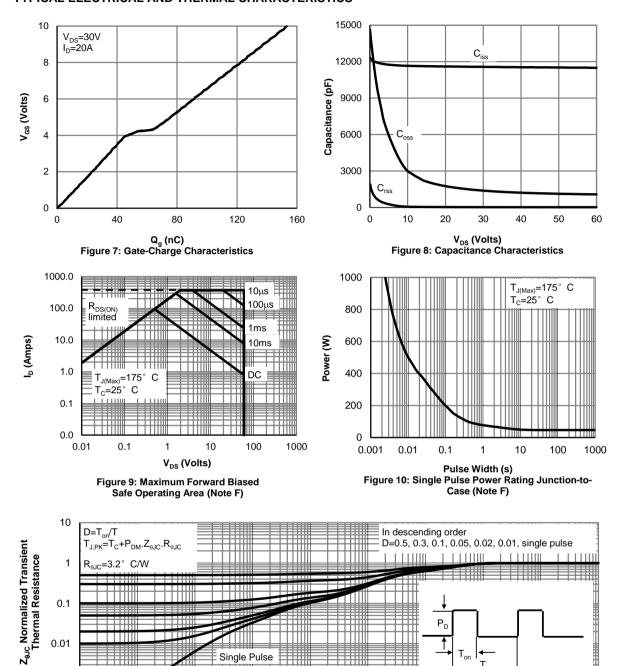
V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

0.1

100

10

1000

0.01

0.001 L 1E-06

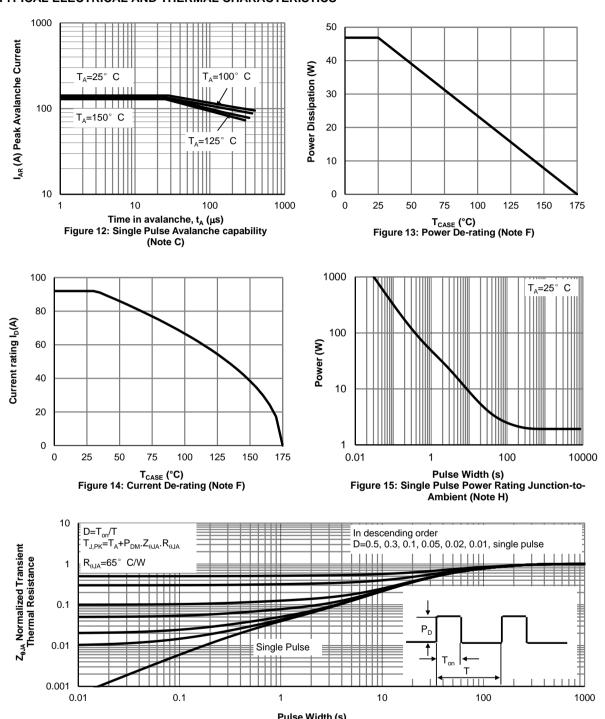
1E-05

0.0001

0.001



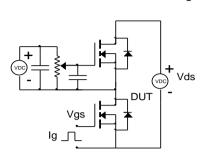
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

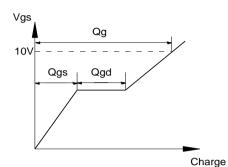


Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

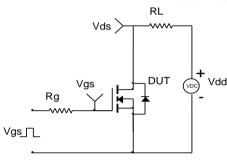


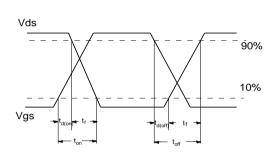
Gate Charge Test Circuit & Waveform



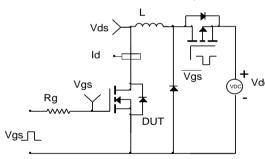


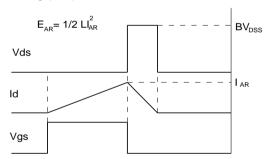
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

